

## Half Bridge, 600 A, DIAP IGBT Power Module (Trench Field Stop IGBT)



Dual INT-A-PAK

### FEATURES

- TrenchStop IGBT technology
- Standard: optimized for hard switching speed
- Low  $V_{CE(on)}$
- Square RBSOA
- Gen 4 FRED Pt<sup>®</sup> dices technology
- Industry standard package
- Al<sub>2</sub>O<sub>3</sub> DBC
- Designed for industrial level
- Material categorization: for definitions of compliance please see [www.vishay.com/doc?99912](http://www.vishay.com/doc?99912)


**RoHS  
COMPLIANT**

| PRIMARY CHARACTERISTICS                |                |
|--|----------------|
| $V_{CES}$                              | 600 V          |
| $I_C$ DC at $T_C = 71\text{ °C}$       | 600 A          |
| $V_{CE(on)}$ (typical) at 600 A, 25 °C | 1.29 V         |
| Speed                                  | DC to 1 kHz    |
| Package                                | Dual INT-A-PAK |
| Circuit configuration                  | Half bridge    |

### BENEFITS

- Increased operating efficiency
- Performance optimized as output inverter stage for TIG welding machines
- Direct mounting on heatsink
- Very low junction to case thermal resistance

| ABSOLUTE MAXIMUM RATINGS          |                      |   |      |       |
|-----------------------------------|----------------------|---|------|-------|
| PARAMETER                         | SYMBOL               | TEST CONDITIONS   | MAX. | UNITS |
| Collector to emitter voltage      | $V_{CES}$            |   | 600  | V     |
| Continuous collector current      | $I_C$ <sup>(1)</sup> | $T_C = 25\text{ °C}$  | 755  | A     |
|                                   |                      | $T_C = 80\text{ °C}$  | 565  |       |
| Pulsed collector current          | $I_{CM}$             | $T_C = 175\text{ °C}$ , $t_p = 6\text{ ms}$ , $V_{GE} = 15\text{ V}$          | 1000 |       |
| Clamped inductive load current    | $I_{LM}$             |   | n/a  |       |
| Diode continuous forward current  | $I_F$                | $T_C = 25\text{ °C}$  | 272  |       |
|                                   |                      | $T_C = 80\text{ °C}$  | 202  |       |
| Gate to emitter voltage           | $V_{GE}$             |   | ± 20 | V     |
| Maximum power dissipation (IGBT)  | $P_D$                | $T_C = 25\text{ °C}$  | 1364 | W     |
|                                   |                      | $T_C = 80\text{ °C}$  | 864  |       |
| Maximum power dissipation (Diode) | $P_D$                | $T_C = 25\text{ °C}$  | 468  | W     |
|                                   |                      | $T_C = 80\text{ °C}$  | 297  |       |
| RMS isolation voltage             | $V_{ISOL}$           | Any terminal to case<br>( $V_{RMS}$ $t = 1\text{ s}$ , $T_J = 25\text{ °C}$ ) | 3500 | V     |

#### Note

<sup>(1)</sup> Maximum continuous collector current must be limited to 500 A to do not exceed the maximum temperature of terminals



| <b>ELECTRICAL SPECIFICATIONS</b> ( $T_J = 25\text{ }^\circ\text{C}$ unless otherwise specified) |               |   |      |            |           |               |
|---|---------------|---|------|------------|-----------|---------------|
| PARAMETER   | SYMBOL        | TEST CONDITIONS   | MIN. | TYP.       | MAX.      | UNITS         |
| Collector to emitter breakdown voltage  | $V_{BR(CES)}$ | $V_{GE} = 0\text{ V}, I_C = 1.2\text{ mA}$  | 600  | -          | -         | V             |
| Collector to emitter voltage  | $V_{CE(on)}$  | $V_{GE} = 15\text{ V}, I_C = 600\text{ A}$  | -    | 1.29       | 1.64      |               |
|   |               | $V_{GE} = 15\text{ V}, I_C = 600\text{ A}, T_J = 125\text{ }^\circ\text{C}$   | -    | 1.36       | -         |               |
| Gate threshold voltage  | $V_{GE(th)}$  | $V_{CE} = V_{GE}, I_C = 6\text{ mA}$  | 3.8  | 4.8        | 6.3       | $\mu\text{A}$ |
| Collector to emitter leakage current  | $I_{CES}$     | $V_{GE} = 0\text{ V}, V_{CE} = 600\text{ V}$<br>$V_{GE} = 0\text{ V}, V_{CE} = 600\text{ V}, T_J = 125\text{ }^\circ\text{C}$ | -    | 0.3<br>280 | 200<br>-  |               |
| Diode forward voltage drop  | $V_{FM}$      | $I_{FM} = 400\text{ A}$   | -    | 1.66       | 2.3       | V             |
|   |               | $I_{FM} = 400\text{ A}, T_J = 125\text{ }^\circ\text{C}$  | -    | 1.57       | -         |               |
| Gate to emitter leakage current   | $I_{GES}$     | $V_{GE} = \pm 20\text{ V}$  | -    | -          | $\pm 200$ | nA            |

| <b>SWITCHING CHARACTERISTICS</b> ( $T_J = 25\text{ }^\circ\text{C}$ unless otherwise specified) |              |  |      |      |      |               |
|---|--------------|--|------|------|------|---------------|
| PARAMETER   | SYMBOL       | TEST CONDITIONS  | MIN. | TYP. | MAX. | UNITS         |
| Total gate charge (turn-on)   | $Q_g$        | $I_C = 75\text{ A}, V_{CC} = 520\text{ V}, V_{GE} = 15\text{ V}$   | -    | 2665 | -    | nC            |
| Gate-to-emitter charge (turn-on)  | $Q_{ge}$     |  | -    | 445  | -    |               |
| Gate-to-collector charge (turn-on)  | $Q_{gc}$     |  | -    | 750  | -    |               |
| Turn-on switching loss  | $E_{on}$     | $I_C = 600\text{ A}, V_{CC} = 300\text{ V}, V_{GE} = 15\text{ V}, R_g = 27\text{ }\Omega, L = 500\text{ }\mu\text{H}, T_J = 25\text{ }^\circ\text{C}$                                    | -    | 75   | -    | mJ            |
| Turn-off switching loss   | $E_{off}$    |  | -    | 72   | -    |               |
| Total switching loss  | $E_{tot}$    |  | -    | 147  | -    |               |
| Turn-on switching loss  | $E_{on}$     |  | -    | 39   | -    |               |
| Turn-off switching loss   | $E_{off}$    |  | -    | 53   | -    |               |
| Total switching loss  | $E_{tot}$    |  | -    | 92   | -    |               |
| Turn-on delay time  | $t_{d(on)}$  | $I_C = 600\text{ A}, V_{CC} = 300\text{ V}, V_{GE} = 15\text{ V}, R_g = 27\text{ }\Omega, L = 500\text{ }\mu\text{H}, T_J = 125\text{ }^\circ\text{C}$                                   | -    | 580  | -    | ns            |
| Rise time   | $t_r$        |  | -    | 290  | -    |               |
| Turn-off delay time   | $t_{d(off)}$ |  | -    | 2540 | -    |               |
| Fall time   | $t_f$        |  | -    | 130  | -    |               |
| Reverse bias safe operating area  | RBSOA        | $T_J = 175\text{ }^\circ\text{C}, I_C = \text{n/a}, V_{CC} = 300\text{ V}, V_p = 600\text{ V}, R_g = 27\text{ }\Omega, V_{GE} = 15\text{ V to } -5\text{ V}, L = 500\text{ }\mu\text{H}$ | n/a  |      |      |               |
| Diode reverse recovery time   | $t_{rr}$     | $I_F = 50\text{ A}, di_F/dt = 500\text{ A}/\mu\text{s}, V_{CC} = 200\text{ V}, T_J = 25\text{ }^\circ\text{C}$   | -    | 152  | -    | ns            |
| Diode peak reverse current  | $I_{rr}$     |  | -    | 24   | -    | A             |
| Diode recovery charge   | $Q_{rr}$     |  | -    | 1.82 | -    | $\mu\text{C}$ |
| Diode reverse recovery time   | $t_{rr}$     | $I_F = 50\text{ A}, di_F/dt = 500\text{ A}/\mu\text{s}, V_{CC} = 200\text{ V}, T_J = 125\text{ }^\circ\text{C}$  | -    | 200  | -    | ns            |
| Diode peak reverse current  | $I_{rr}$     |  | -    | 39   | -    | A             |
| Diode recovery charge   | $Q_{rr}$     |  | -    | 3.94 | -    | $\mu\text{C}$ |

| <b>THERMAL AND MECHANICAL SPECIFICATIONS</b> |                                    |      |      |      |                           |  |
|--|------------------------------------|------|------|------|---------------------------|--|
| PARAMETER                                    | SYMBOL                             | MIN. | TYP. | MAX. | UNITS                     |  |
| Operating junction temperature range         | $T_J$                              | -40  | -    | 175  | $^\circ\text{C}$          |  |
| Storage temperature range                    | $T_{Stg}$                          | -40  | -    | 150  | $^\circ\text{C}$          |  |
| Junction to case per leg                     | IGBT                               | -    | -    | 0.11 | $^\circ\text{C}/\text{W}$ |  |
|  | Diode                              |      |      |      |                           |  |
| Case to sink per module                      | $R_{thCS}$                         | -    | 0.05 | -    |                           |  |
| Mounting torque                              | case to heatsink: M6 screw         | 2.5  | -    | 5    | Nm                        |  |
|  | case to terminal 1, 2, 3: M6 screw | 3    | -    | 5    |                           |  |
| Weight                                       |                                    | -    | 270  | -    | g                         |  |

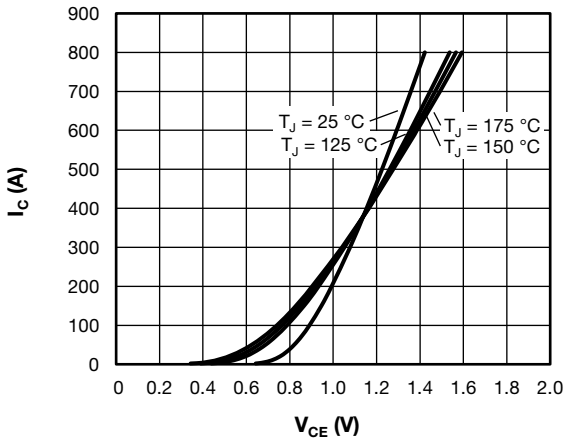


Fig. 1 - Typical Q1 to Q2 IGBT Output Characteristics,  $V_{GE} = 15\text{ V}$

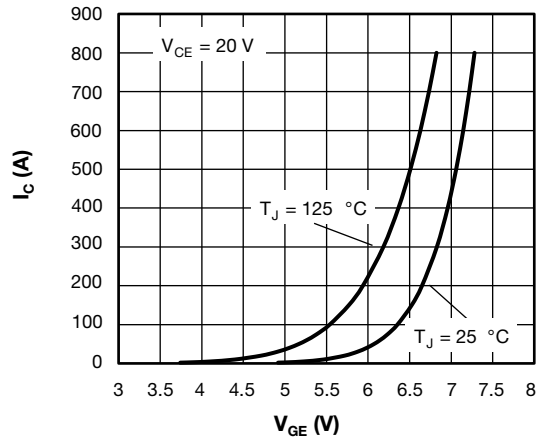


Fig. 4 - Typical Q1 to Q2 IGBT Transfer Characteristics

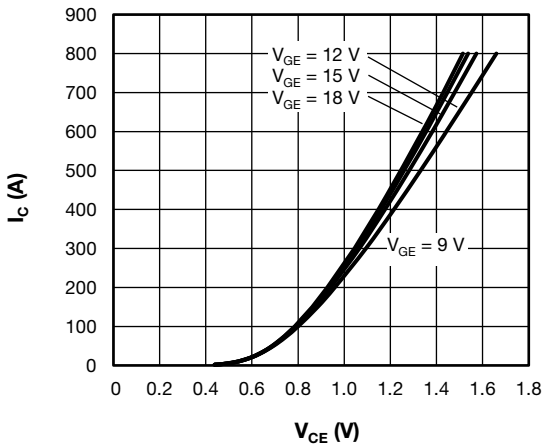


Fig. 2 - Typical Q1 to Q2 IGBT Output Characteristics,  $T_J = 125\text{ °C}$

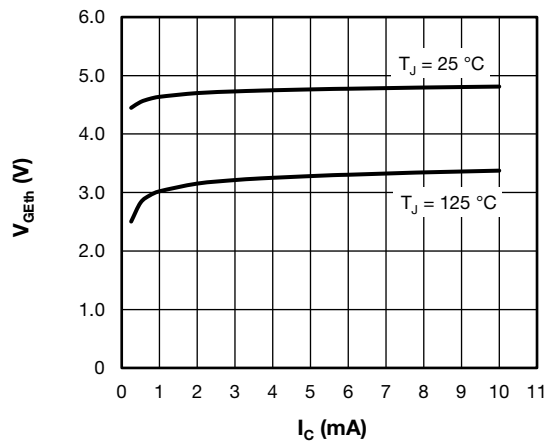


Fig. 5 - Typical Q1 to Q2 IGBT Gate Threshold Voltage

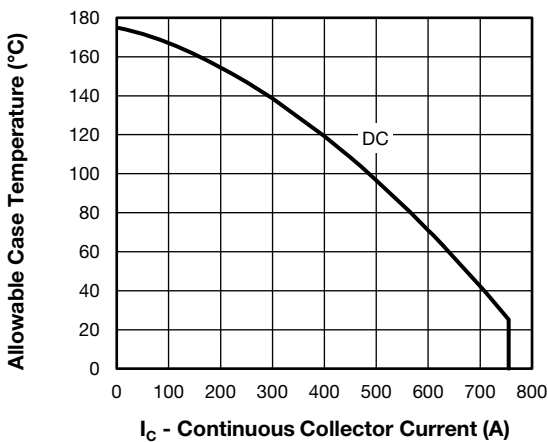


Fig. 3 - Maximum Q1 to Q2 IGBT Continuous Collector Current vs. Case Temperature

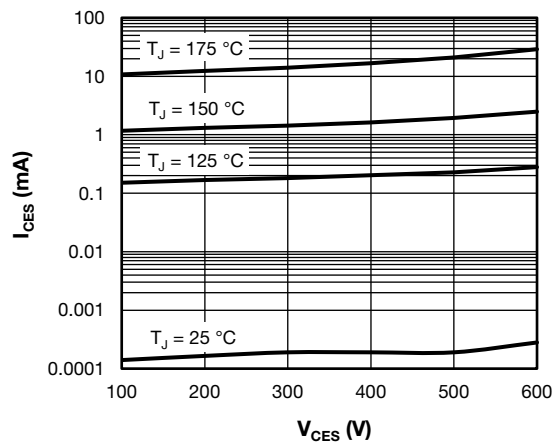


Fig. 6 - Typical Q1 to Q2 IGBT Zero Gate Voltage Collector Current

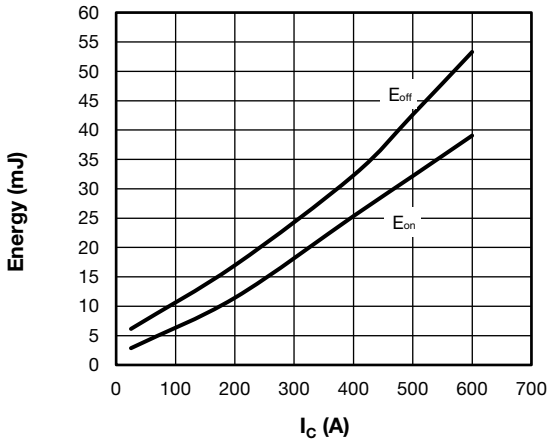


Fig. 7 - Typical Q1 to Q2 IGBT Energy Loss vs.  $I_C$   
(with D1 to D2 Antiparallel Diode)  
 $T_J = 125^\circ\text{C}$ ,  $V_{CC} = 300\text{ V}$ ,  $R_g = 27\ \Omega$ ,  $V_{GE} = +15\text{ V}/-15\text{ V}$ ,  $L = 500\ \mu\text{H}$

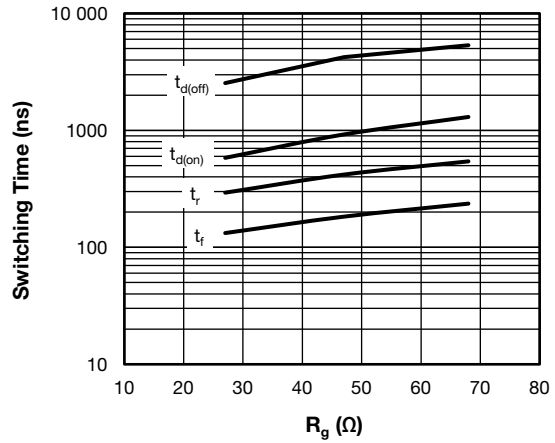


Fig. 10 - Typical Q1 to Q2 IGBT Switching Time vs.  $R_g$   
(with D1 to D2 Antiparallel Diode)  
 $T_J = 125^\circ\text{C}$ ,  $V_{CC} = 300\text{ V}$ ,  $I_C = 600\text{ A}$ ,  $V_{GE} = +15\text{ V}/-15\text{ V}$ ,  $L = 500\ \mu\text{H}$

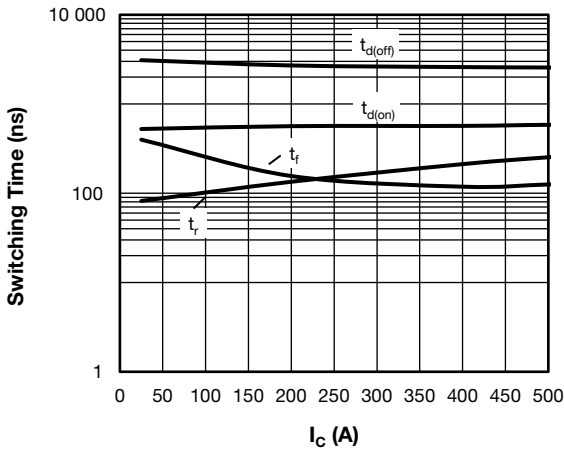


Fig. 8 - Typical Q1 to Q2 IGBT Switching Time vs.  $I_C$   
(with D1 to D2 Antiparallel Diode)  
 $T_J = 125^\circ\text{C}$ ,  $V_{CC} = 300\text{ V}$ ,  $R_g = 27\ \Omega$ ,  $V_{GE} = +15\text{ V}/-15\text{ V}$ ,  $L = 500\ \mu\text{H}$

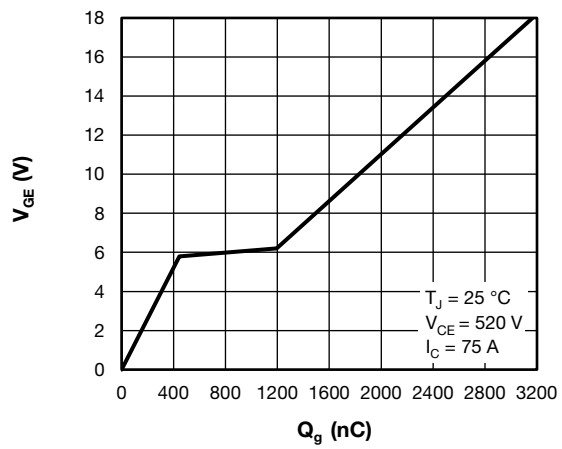


Fig. 11 - Typical Q1 to Q2 IGBT Gate Charge vs. Gate to Source Voltage

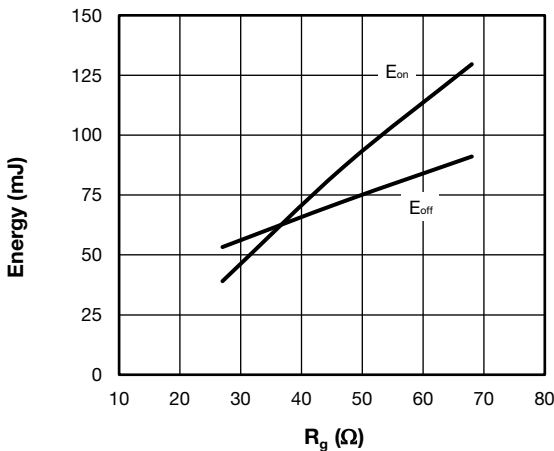


Fig. 9 - Typical Q1 to Q2 IGBT Energy Loss vs.  $R_g$   
(with D1 to D2 Antiparallel Diode)  
 $T_J = 125^\circ\text{C}$ ,  $V_{CC} = 300\text{ V}$ ,  $I_C = 600\text{ A}$ ,  $V_{GE} = +15\text{ V}/-15\text{ V}$ ,  $L = 500\ \mu\text{H}$

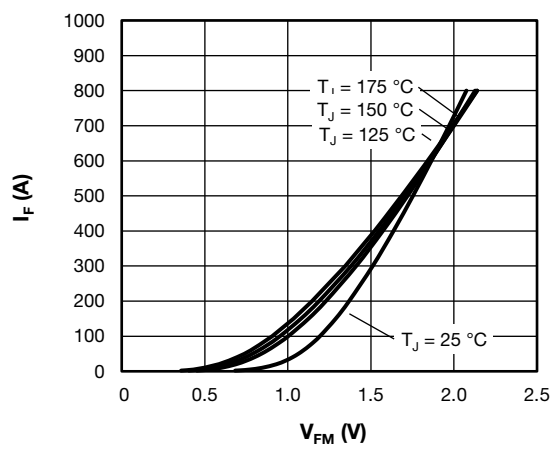


Fig. 12 - Typical D1 to D2 Antiparallel Diode Forward Characteristics

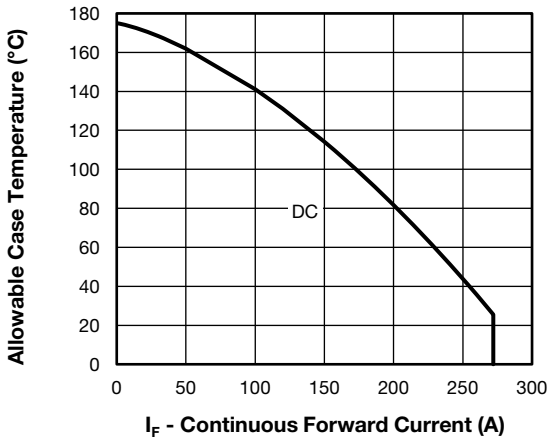


Fig. 13 - Maximum D1 to D2 Antiparallel Diode Continuous Forward Current vs. Case Temperature

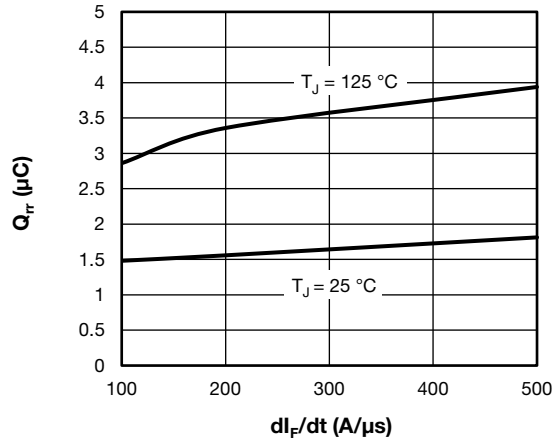


Fig. 16 - Typical D1 to D2 Antiparallel Diode Reverse Recovery Charge vs.  $di_F/dt$   
 $V_{rr} = 200\text{ V}$ ,  $I_F = 50\text{ A}$

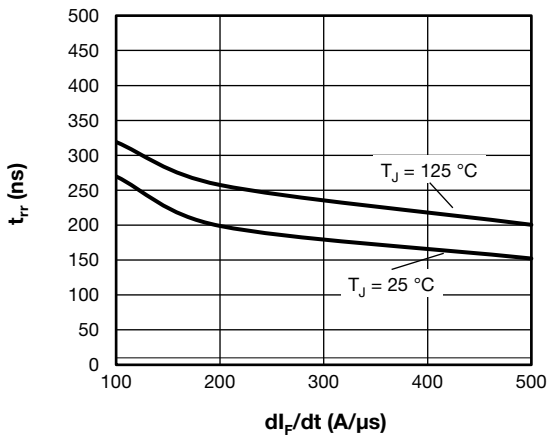


Fig. 14 - Typical D1 to D2 Antiparallel Diode Reverse Recovery Time vs.  $di_F/dt$   
 $V_{rr} = 200\text{ V}$ ,  $I_F = 50\text{ A}$

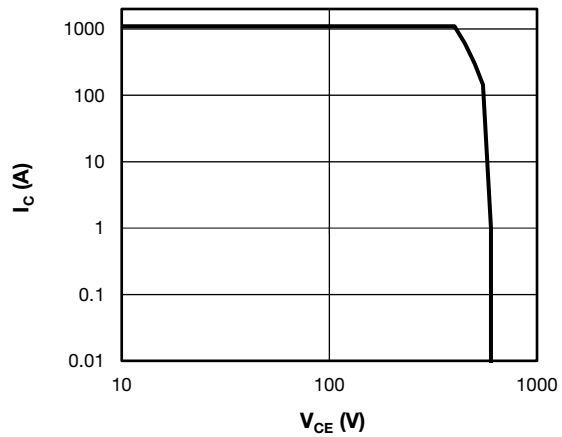


Fig. 17 - Q1 to Q2 IGBT Reverse BIAS SOA  $T_J = 175^\circ\text{C}$ ,  $V_{GE} = 15\text{ V}$ ,  $T_J = 175^\circ\text{C}$ ,  $I_C = 1100\text{ A}$ ,  $R_{\theta} = 27\ \Omega$ ,  $V_{GE} = +15\text{ V/0 V}$ ,  $V_{CC} = 400\text{ V}$ ,  $V_p = 600\text{ V}$

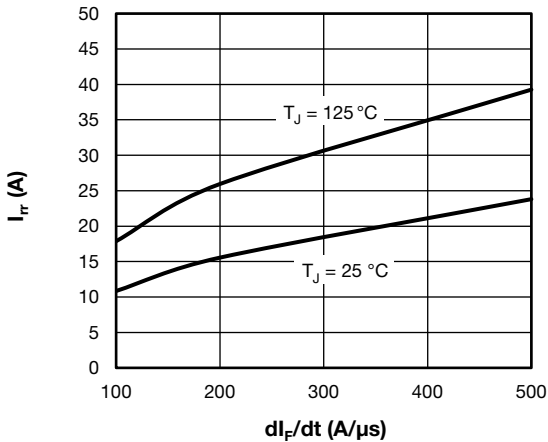


Fig. 15 - Typical D1 to D2 Antiparallel Diode Reverse Recovery Current vs.  $di_F/dt$   
 $V_{rr} = 200\text{ V}$ ,  $I_F = 50\text{ A}$

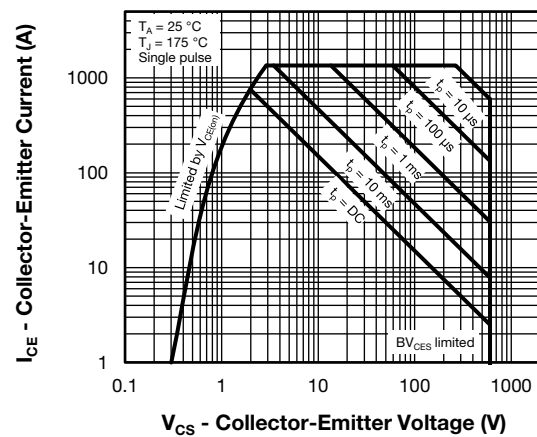


Fig. 18 - Q1 to Q2 IGBT Safe Operating Area

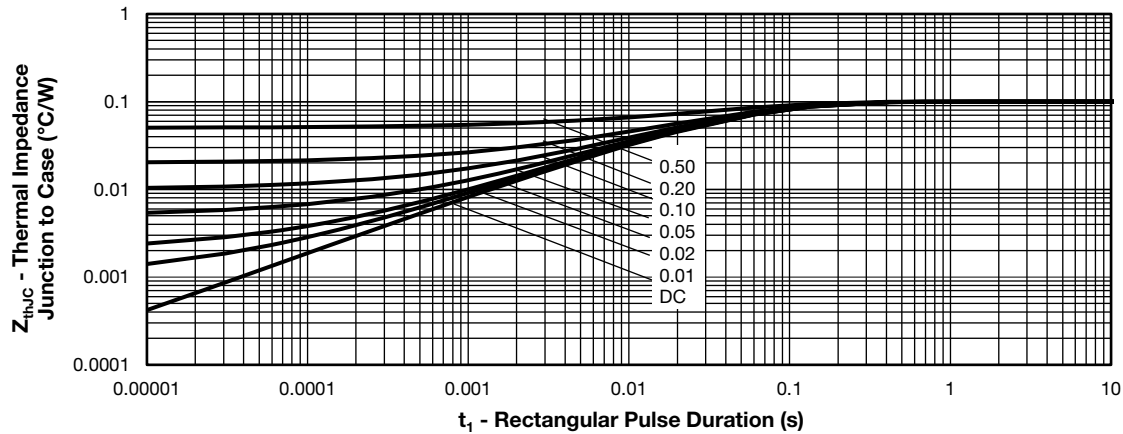


Fig. 19 - Maximum Thermal Impedance  $Z_{thJC}$  Characteristics - (Q1 to Q2 PT IGBT)

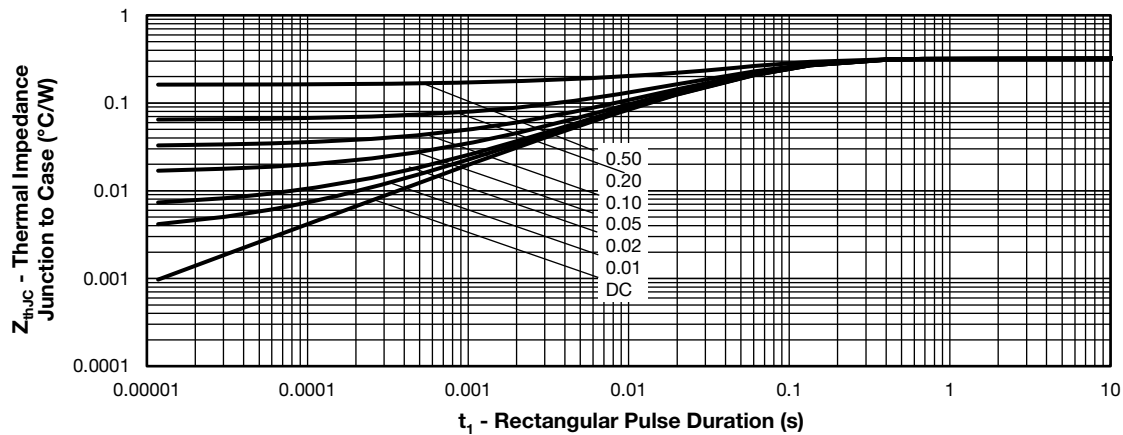


Fig. 20 - Maximum Thermal Impedance  $Z_{thJC}$  Characteristics - (D1 to D2 Antiparallel Diode)

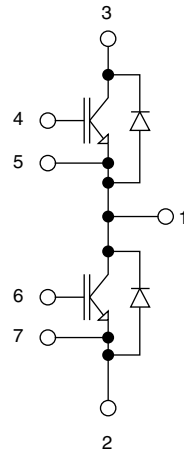
**ORDERING INFORMATION TABLE**

|             |          |          |            |          |          |            |          |
|-------------|----------|----------|------------|----------|----------|------------|----------|
| Device code | <b>G</b> | <b>T</b> | <b>600</b> | <b>T</b> | <b>H</b> | <b>060</b> | <b>S</b> |
|             | ①        | ②        | ③          | ④        | ⑤        | ⑥          | ⑦        |

- 1** - Insulated gate bipolar transistor (IGBT)
- 2** - T = Trench IGBT technology
- 3** - Current rating (600 = 600 A)
- 4** - Circuit configuration (T = half-bridge)
- 5** - Package indicator (H = dual INT-A-PAK)
- 6** - Voltage rating (060 = 600 V)
- 7** - Speed / type (S = standard speed IGBT)

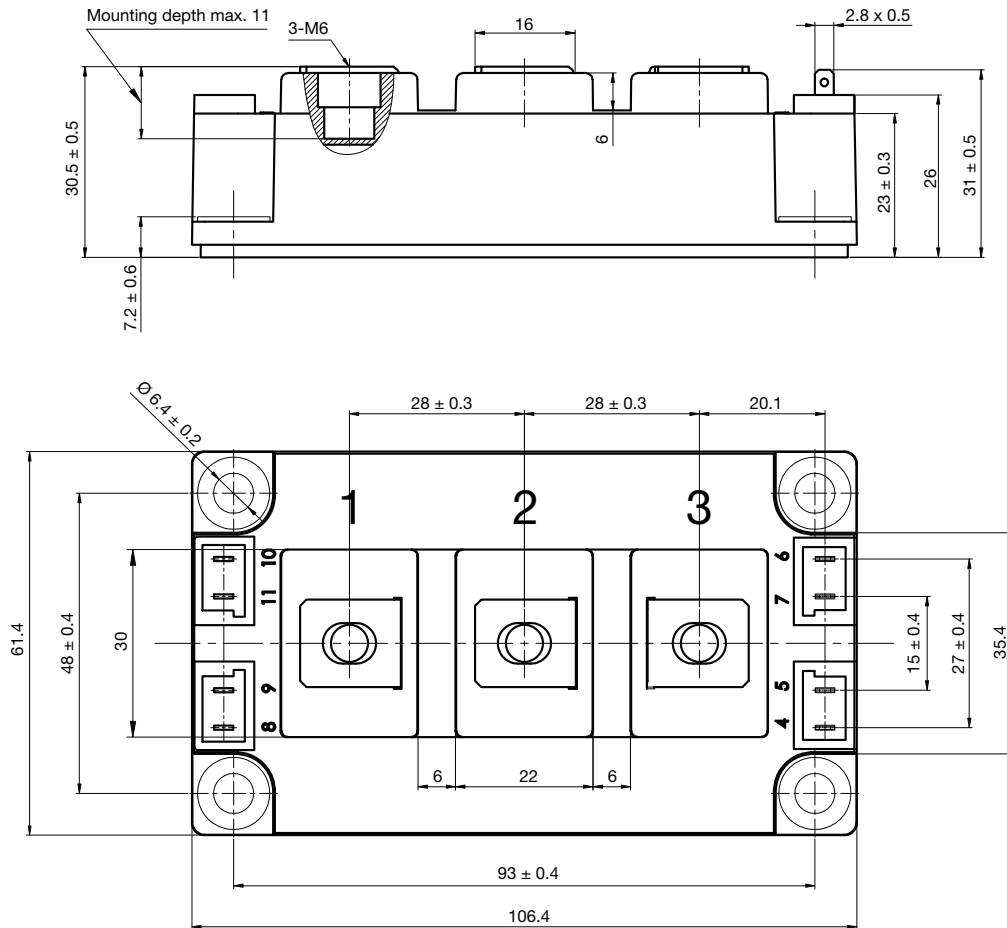


CIRCUIT CONFIGURATION



| LINKS TO RELATED DOCUMENTS |  |
|----------------------------|--|
| Dimensions                 | <a href="http://www.vishay.com/doc?95435">www.vishay.com/doc?95435</a> |
| Application Note           | <a href="http://www.vishay.com/doc?95553">www.vishay.com/doc?95553</a> |

DIMENSIONS in millimeters





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